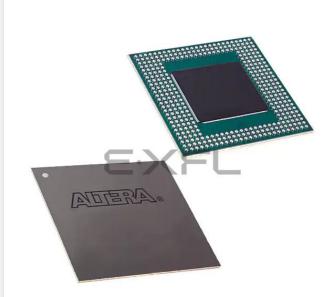
# E·XF

## Intel - EPF10K100ABC356-1 Datasheet



Welcome to <u>E-XFL.COM</u>

## Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Det	ta	i	s

Details	
Product Status	Obsolete
Number of LABs/CLBs	624
Number of Logic Elements/Cells	4992
Total RAM Bits	24576
Number of I/O	274
Number of Gates	158000
Voltage - Supply	3V ~ 3.6V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	356-LBGA
Supplier Device Package	356-BGA (35x35)
Purchase URL	https://www.e-xfl.com/product-detail/intel/epf10k100abc356-1

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Table 2. FLEX 10K Device	Features			
Feature	EPF10K70	EPF10K100 EPF10K100A	EPF10K130V	EPF10K250A
Typical gates (logic and RAM) (1)	70,000	100,000	130,000	250,000
Maximum system gates	118,000	158,000	211,000	310,000
LEs	3,744	4,992	6,656	12,160
LABs	468	624	832	1,520
EABs	9	12	16	20
Total RAM bits	18,432	24,576	32,768	40,960
Maximum user I/O pins	358	406	470	470

#### Note to tables:

(1) The embedded IEEE Std. 1149.1 JTAG circuitry adds up to 31,250 gates in addition to the listed typical or maximum system gates.

# ...and More Features

- Devices are fabricated on advanced processes and operate with a 3.3-V or 5.0-V supply voltage (see Table 3
- In-circuit reconfigurability (ICR) via external configuration device, intelligent controller, or JTAG port
- ClockLock<sup>™</sup> and ClockBoost<sup>™</sup> options for reduced clock delay/skew and clock multiplication
- Built-in low-skew clock distribution trees
- 100% functional testing of all devices; test vectors or scan chains are not required

Table 3. Supply Voltages for FLEX 10K & FLEX 10KA Devices		
5.0-V Devices	3.3-V Devices	
EPF10K10	EPF10K10A	
EPF10K20	EPF10K30A	
EPF10K30	EPF10K50V	
EPF10K40	EPF10K100A	
EPF10K50	EPF10K130V	
EPF10K70	EPF10K250A	
EPF10K100		

- Flexible interconnect
  - FastTrack<sup>®</sup> Interconnect continuous routing structure for fast, predictable interconnect delays
  - Dedicated carry chain that implements arithmetic functions such as fast adders, counters, and comparators (automatically used by software tools and megafunctions)
  - Dedicated cascade chain that implements high-speed, high-fan-in logic functions (automatically used by software tools and megafunctions)
  - Tri-state emulation that implements internal tri-state buses
  - Up to six global clock signals and four global clear signals
- Powerful I/O pins
  - Individual tri-state output enable control for each pin
  - Open-drain option on each I/O pin
  - Programmable output slew-rate control to reduce switching noise
  - FLEX 10KA devices support hot-socketing
- Peripheral register for fast setup and clock-to-output delay
- Flexible package options
  - Available in a variety of packages with 84 to 600 pins (see Tables 4 and 5)
  - Pin-compatibility with other FLEX 10K devices in the same package
  - FineLine BGA<sup>™</sup> packages maximize board space efficiency
- Software design support and automatic place-and-route provided by Altera development systems for Windows-based PCs and Sun SPARCstation, HP 9000 Series 700/800 workstations
- Additional design entry and simulation support provided by EDIF 2 0 0 and 3 0 0 netlist files, library of parameterized modules (LPM), DesignWare components, Verilog HDL, VHDL, and other interfaces to popular EDA tools from manufacturers such as Cadence, Exemplar Logic, Mentor Graphics, OrCAD, Synopsys, Synplicity, VeriBest, and Viewlogic

#### Notes to tables:

- (1)FLEX 10K and FLEX 10KA device package types include plastic J-lead chip carrier (PLCC), thin quad flat pack (TQFP), plastic quad flat pack (PQFP), power quad flat pack (RQFP), ball-grid array (BGA), pin-grid array (PGA), and FineLine BGA<sup>™</sup> packages.
- This option is supported with a 256-pin FineLine BGA package. By using SameFrame pin migration, all FineLine (2) BGA packages are pin compatible. For example, a board can be designed to support both 256-pin and 484-pin FineLine BGA packages. The Altera software automatically avoids conflicting pins when future migration is set.

# General Description

Altera's FLEX 10K devices are the industry's first embedded PLDs. Based on reconfigurable CMOS SRAM elements, the Flexible Logic Element MatriX (FLEX) architecture incorporates all features necessary to implement common gate array megafunctions. With up to 250,000 gates, the FLEX 10K family provides the density, speed, and features to integrate entire systems, including multiple 32-bit buses, into a single device.

FLEX 10K devices are reconfigurable, which allows 100% testing prior to shipment. As a result, the designer is not required to generate test vectors for fault coverage purposes. Additionally, the designer does not need to manage inventories of different ASIC designs; FLEX 10K devices can be configured on the board for the specific functionality required.

Table 6 shows FLEX 10K performance for some common designs. All performance values were obtained with Synopsys DesignWare or LPM functions. No special design technique was required to implement the applications; the designer simply inferred or instantiated a function in a Verilog HDL, VHDL, Altera Hardware Description Language (AHDL), or schematic design file.

Table 6. FLEX 10K &	able 6. FLEX 10K & FLEX 10KA Performance						
Application	Resources Used			Performance			Units
	LEs	EABs	-1 Speed Grade	-2 Speed Grade	-3 Speed Grade	-4 Speed Grade	
16-bit loadable counter (1)	16	0	204	166	125	95	MHz
16-bit accumulator (1)	16	0	204	166	125	95	MHz
16-to-1 multiplexer (2)	10	0	4.2	5.8	6.0	7.0	ns
$256 \times 8$ RAM read cycle speed (3)	0	1	172	145	108	84	MHz
$256 \times 8$ RAM write cycle speed (3)	0	1	106	89	68	63	MHz

## 

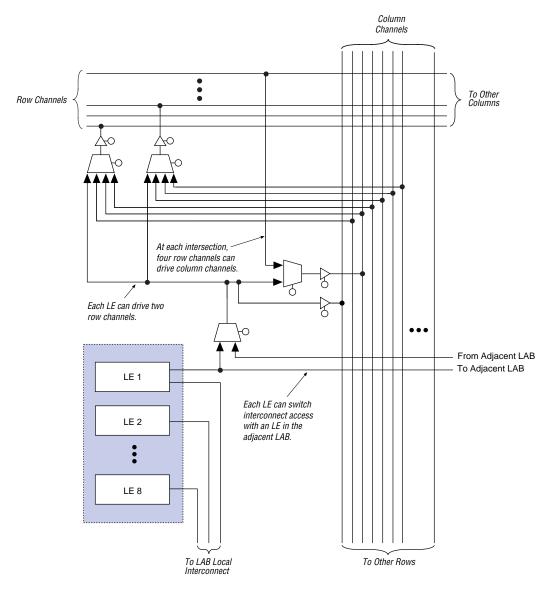
#### Notes:

(1) The speed grade of this application is limited because of clock high and low specifications.

This application uses combinatorial inputs and outputs. (2)

This application uses registered inputs and outputs. (3)

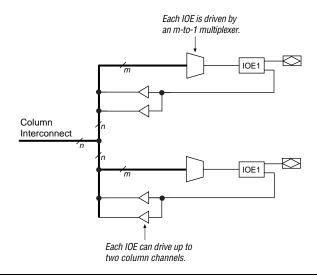
#### Altera Corporation



## Figure 11. LAB Connections to Row & Column Interconnect

## Figure 15. FLEX 10K Column-to-IOE Connections

The values for m and n are provided in Table 11.



### Table 11 lists the FLEX 10K column-to-IOE interconnect resources.

Table 11. FLEX 10	K Column-to-IOE Interconned	ct Resources
Device	Channels per Column ( <i>n</i> )	Column Channel per Pin ( <i>m</i> )
EPF10K10 EPF10K10A	24	16
EPF10K20	24	16
EPF10K30 EPF10K30A	24	16
EPF10K40	24	16
EPF10K50 EPF10K50V	24	16
EPF10K70	24	16
EPF10K100 EPF10K100A	24	16
EPF10K130V	32	24
EPF10K250A	40	32

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>IH</sub>	High-level input voltage		2.0		5.75	V
VIL	Low-level input voltage		-0.5		0.8	V
V <sub>OH</sub>	3.3-V high-level TTL output voltage	I <sub>OH</sub> = -8 mA DC <i>(8)</i>	2.4			V
	3.3-V high-level CMOS output voltage	I <sub>OH</sub> = -0.1 mA DC <i>(8)</i>	V <sub>CCIO</sub> – 0.2			V
V <sub>OL</sub>	3.3-V low-level TTL output voltage	I <sub>OL</sub> = 8 mA DC <i>(9)</i>			0.45	V
-	3.3-V low-level CMOS output voltage	I <sub>OL</sub> = 0.1 mA DC <i>(9)</i>			0.2	V
I <sub>I</sub>	Input pin leakage current	V <sub>I</sub> = 5.3 V to -0.3 V (10)	-10		10	μA
I <sub>OZ</sub>	Tri-stated I/O pin leakage current	$V_{\rm O} = 5.3 \text{ V to } -0.3 \text{ V} (10)$	-10		10	μA
I <sub>CC0</sub>	V <sub>CC</sub> supply current (standby)	V <sub>I</sub> = ground, no load		0.3	10	mA
		$V_1$ = ground, no load (11)		10		mA

Table 2	5. EPF10K50V & EPF10K130V D	<i>Nevice Capacitance</i> (12)			
Symbol	Parameter	Conditions	Min	Max	Unit
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		10	pF
CINCLK	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		15	pF
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		10	pF

#### Notes to tables:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC input voltage is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) Numbers in parentheses are for industrial-temperature-range devices.
- (4) Maximum  $V_{CC}$  rise time is 100 ms.  $V_{CC}$  must rise monotonically.
- (5) EPF10K50V and EPF10K130V device inputs may be driven before V<sub>CCINT</sub> and V<sub>CCIO</sub> are powered.
- (6) Typical values are for  $T_A = 25^\circ \text{ C}$  and  $V_{CC} = 3.3 \text{ V}$ .
- (7) These values are specified under the EPF10K50V and EPF10K130V device Recommended Operating Conditions in Table 23 on page 48.
- (8) The I<sub>OH</sub> parameter refers to high-level TTL or CMOS output current.
- (9) The I<sub>OL</sub> parameter refers to low-level TTL or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (10) This value is specified for normal device operation. The value may vary during power-up.
- (11) This parameter applies to -1 speed grade EPF10K50V devices, -2 speed grade EPF10K50V industrial temperature devices, and -2 speed grade EPF10K130V devices.
- (12) Capacitance is sample-tested only.

#### FLEX 10K Embedded Programmable Logic Device Family Data Sheet

Table 2	9. 3.3-V Device Capacitance of	EPF10K10A & EPF10K30A Devices	Note (12)		
Symbol	Parameter	Conditions	Min	Max	Unit
CIN	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		8	pF
CINCLK	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		12	pF
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		8	pF

#### Table 30. 3.3-V Device Capacitance of EPF10K100A Devices Note (12)

Symbol	Parameter	Conditions	Min	Max	Unit
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		10	pF
C <sub>INCLK</sub>	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		15	pF
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		10	pF

## Table 31. 3.3-V Device Capacitance of EPF10K250A Devices Note (12)

Symbol	Parameter	Conditions	Min	Max	Unit
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		10	pF
C <sub>INCLK</sub>	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		15	pF
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		10	pF

#### Notes to tables:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC voltage input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) Numbers in parentheses are for industrial-temperature-range devices.
- (4) Maximum  $V_{CC}$  rise time is 100 ms, and  $V_{CC}$  must rise monotonically.
- (5) FLEX 10KA device inputs may be driven before V<sub>CCINT</sub> and V<sub>CCIO</sub> are powered.
- (6) Typical values are for  $T_A = 25^\circ$  C and  $V_{CC} = 3.3$  V.
- (7) These values are specified under the Recommended Operating Conditions shown in Table 27 on page 51.
- (8) The I<sub>OH</sub> parameter refers to high-level TTL, PCI, or CMOS output current.
- (9) The I<sub>OL</sub> parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (10) This value is specified for normal device operation. The value may vary during power-up.
- (11) This parameter applies to all -1 speed grade commercial temperature devices and all -2 speed grade industrial-temperature devices.
- (12) Capacitance is sample-tested only.

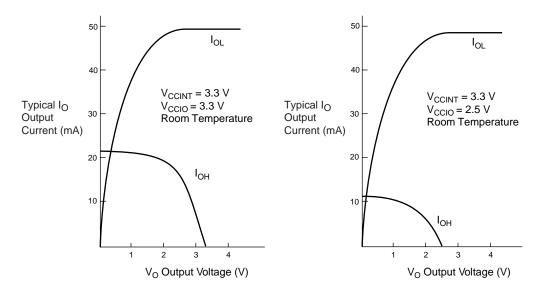


Figure 23. Output Drive Characteristics for EPF10K250A Device

# Timing Model

The continuous, high-performance FastTrack Interconnect routing resources ensure predictable performance and accurate simulation and timing analysis. This predictable performance contrasts with that of FPGAs, which use a segmented connection scheme and therefore have unpredictable performance.

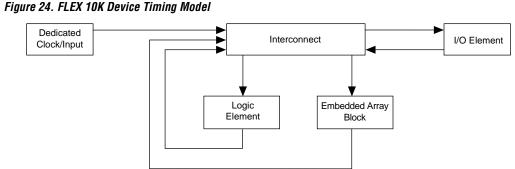
Device performance can be estimated by following the signal path from a source, through the interconnect, to the destination. For example, the registered performance between two LEs on the same row can be calculated by adding the following parameters:

- LE register clock-to-output delay  $(t_{CO})$
- Interconnect delay (*t*<sub>SAMEROW</sub>)
- LE look-up table delay ( $t_{LUT}$ )
- LE register setup time  $(t_{SU})$

The routing delay depends on the placement of the source and destination LEs. A more complex registered path may involve multiple combinatorial LEs between the source and destination LEs.

Timing simulation and delay prediction are available with the MAX+PLUS II Simulator and Timing Analyzer, or with industrystandard EDA tools. The Simulator offers both pre-synthesis functional simulation to evaluate logic design accuracy and post-synthesis timing simulation with 0.1-ns resolution. The Timing Analyzer provides pointto-point timing delay information, setup and hold time analysis, and device-wide performance analysis.

Figure 24 shows the overall timing model, which maps the possible paths to and from the various elements of the FLEX 10K device.



Symbol	-3 Spee	d Grade	-4 Spee	d Grade	Unit
	Min	Max	Min	Max	
t <sub>EABDATA1</sub>		1.5		1.9	ns
t <sub>EABDATA2</sub>		4.8		6.0	ns
t <sub>EABWE1</sub>		1.0		1.2	ns
t <sub>EABWE2</sub>		5.0		6.2	ns
t <sub>EABCLK</sub>		1.0		2.2	ns
t <sub>EABCO</sub>		0.5		0.6	ns
t <sub>EABBYPASS</sub>		1.5		1.9	ns
t <sub>EABSU</sub>	1.5		1.8		ns
t <sub>EABH</sub>	2.0		2.5		ns
t <sub>AA</sub>		8.7		10.7	ns
t <sub>WP</sub>	5.8		7.2		ns
t <sub>WDSU</sub>	1.6		2.0		ns
t <sub>WDH</sub>	0.3		0.4		ns
t <sub>WASU</sub>	0.5		0.6		ns
t <sub>WAH</sub>	1.0		1.2		ns
t <sub>WO</sub>		5.0		6.2	ns
t <sub>DD</sub>		5.0		6.2	ns
t <sub>EABOUT</sub>		0.5		0.6	ns
t <sub>EABCH</sub>	4.0		4.0		ns
t <sub>EABCL</sub>	5.8		7.2		ns

Symbol	-3 Speed Grade		-4 Spee	Unit	
	Min	Max	Min	Max	
t <sub>IOD</sub>		0.4		0.6	ns
t <sub>IOC</sub>		0.5		0.9	ns
t <sub>IOCO</sub>		0.4		0.5	ns
t <sub>IOCOMB</sub>		0.0		0.0	ns
t <sub>IOSU</sub>	3.1		3.5		ns
t <sub>IOH</sub>	1.0		1.9		ns
t <sub>IOCLR</sub>		1.0		1.2	ns
t <sub>OD1</sub>		3.3		3.6	ns
t <sub>OD2</sub>		5.6		6.5	ns
t <sub>OD3</sub>		7.0		8.3	ns
t <sub>XZ</sub>		5.2		5.5	ns
t <sub>ZX1</sub>		5.2		5.5	ns
t <sub>ZX2</sub>		7.5		8.4	ns
t <sub>ZX3</sub>		8.9		10.2	ns
t <sub>INREG</sub>		7.7		10.0	ns
t <sub>IOFD</sub>		3.3		4.0	ns
t <sub>INCOMB</sub>		3.3		4.0	ns

Symbol	-3 Spee	d Grade	-4 Spee	ed Grade	Unit
	Min	Max	Min	Max	
t <sub>DIN2IOE</sub>		8.4		10.2	ns
t <sub>DIN2LE</sub>		3.6		4.8	ns
t <sub>DIN2DATA</sub>		5.5		7.2	ns
t <sub>DCLK2IOE</sub>		4.6		6.2	ns
t <sub>DCLK2LE</sub>		3.6		4.8	ns
t <sub>SAMELAB</sub>		0.3		0.3	ns
t <sub>SAMEROW</sub>		3.3		3.7	ns
<i>t</i> SAMECOLUMN		3.9		4.1	ns
t <sub>DIFFROW</sub>		7.2		7.8	ns
t <sub>TWOROWS</sub>		10.5		11.5	ns
t <sub>LEPERIPH</sub>		7.5		8.2	ns
t <sub>LABCARRY</sub>		0.4		0.6	ns
t <sub>LABCASC</sub>		2.4		3.0	ns

Symbol	-3 Spee	d Grade	-4 Spee	d Grade	Unit
	Min	Max	Min	Max	
t <sub>DRR</sub>		17.2		21.1	ns
t <sub>INSU</sub> (2), (3)	5.7		6.4		ns
t <sub>INH</sub> (3)	0.0		0.0		ns
<b>t</b> оитсо (3)	2.0	8.8	2.0	11.2	ns

Table 56. EPF10K30, EPF10K40 & EPF10K50 Device External Bidirectional Timing Parameters       Note (									
Symbol	-3 Spe	-3 Speed Grade		ed Grade	Unit				
	Min	Max	Min	Max					
t <sub>INSUBIDIR</sub>	4.1		4.6		ns				
t <sub>INHBIDIR</sub>	0.0		0.0		ns				
toutcobidir	2.0	8.8	2.0	11.2	ns				
t <sub>XZBIDIR</sub>		12.3		15.0	ns				
t <sub>ZXBIDIR</sub>		12.3		15.0	ns				

Symbol	-2 Speed	-2 Speed Grade		-3 Speed Grade		-4 Speed Grade	
	Min	Max	Min	Max	Min	Max	-
t <sub>EABAA</sub>		12.1		13.7		17.0	ns
t <sub>EABRCCOMB</sub>	12.1		13.7		17.0		ns
t <sub>EABRCREG</sub>	8.6		9.7		11.9		ns
t <sub>EABWP</sub>	5.2		5.8		7.2		ns
t <sub>EABWCCOMB</sub>	6.5		7.3		9.0		ns
t <sub>EABWCREG</sub>	11.6		13.0		16.0		ns
t <sub>EABDD</sub>		8.8		10.0		12.5	ns
t <sub>EABDATACO</sub>		1.7		2.0		3.4	ns
t <sub>EABDATASU</sub>	4.7		5.3		5.6		ns
t <sub>EABDATAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWESU</sub>	4.9		5.5		5.8		ns
t <sub>EABWEH</sub>	0.0		0.0		0.0		ns
t <sub>EABWDSU</sub>	1.8		2.1		2.7		ns
t <sub>EABWDH</sub>	0.0		0.0		0.0		ns
t <sub>EABWASU</sub>	4.1		4.7		5.8		ns
t <sub>EABWAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWO</sub>		8.4		9.5		11.8	ns

Symbol	-3DX Sne	-3DX Speed Grade		-3 Speed Grade		-4 Speed Grade	
oymbol	Min	Max	Min	Max	Min	Max	Unit
	IVIII		IVIII		IVIIII	-	
t <sub>EABDATA1</sub>		1.5		1.5		1.9	ns
t <sub>EABDATA2</sub>		4.8		4.8		6.0	ns
t <sub>EABWE1</sub>		1.0		1.0		1.2	ns
t <sub>EABWE2</sub>		5.0		5.0		6.2	ns
t <sub>EABCLK</sub>		1.0		1.0		2.2	ns
t <sub>EABCO</sub>		0.5		0.5		0.6	ns
t <sub>EABBYPASS</sub>		1.5		1.5		1.9	ns
t <sub>EABSU</sub>	1.5		1.5		1.8		ns
t <sub>EABH</sub>	2.0		2.0		2.5		ns
t <sub>AA</sub>		8.7		8.7		10.7	ns
t <sub>WP</sub>	5.8		5.8		7.2		ns
t <sub>WDSU</sub>	1.6		1.6		2.0		ns
t <sub>WDH</sub>	0.3		0.3		0.4		ns
t <sub>WASU</sub>	0.5		0.5		0.6		ns
t <sub>WAH</sub>	1.0		1.0		1.2		ns
t <sub>WO</sub>		5.0		5.0		6.2	ns
t <sub>DD</sub>		5.0		5.0		6.2	ns
t <sub>EABOUT</sub>		0.5		0.5		0.6	ns
t <sub>EABCH</sub>	4.0		4.0		4.0		ns
t <sub>EABCL</sub>	5.8		5.8	ĺ	7.2		ns

Symbol	-3DX Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit	
	Min	Max	Min	Max	Min	Max		
t <sub>EABAA</sub>		13.7		13.7		17.0	ns	
t <sub>EABRCCOMB</sub>	13.7		13.7		17.0		ns	
t <sub>EABRCREG</sub>	9.7		9.7		11.9		ns	
t <sub>EABWP</sub>	5.8		5.8		7.2		ns	
t <sub>EABWCCOMB</sub>	7.3		7.3		9.0		ns	
t <sub>EABWCREG</sub>	13.0		13.0		16.0		ns	
t <sub>EABDD</sub>		10.0		10.0		12.5	ns	
t <sub>EABDATACO</sub>		2.0		2.0		3.4	ns	
t <sub>EABDATASU</sub>	5.3		5.3		5.6		ns	
t <sub>EABDATAH</sub>	0.0		0.0		0.0		ns	
t <sub>EABWESU</sub>	5.5		5.5		5.8		ns	
t <sub>EABWEH</sub>	0.0		0.0		0.0		ns	
t <sub>EABWDSU</sub>	5.5		5.5		5.8		ns	
t <sub>EABWDH</sub>	0.0		0.0		0.0		ns	
t <sub>EABWASU</sub>	2.1		2.1		2.7		ns	
t <sub>EABWAH</sub>	0.0		0.0		0.0		ns	
t <sub>EABWO</sub>		9.5		9.5		11.8	ns	

Symbol	-2 Spee	-2 Speed Grade		-3 Speed Grade		-4 Speed Grade	
	Min	Мах	Min	Max	Min	Max	1
t <sub>EABAA</sub>		11.2		14.2		14.2	ns
t <sub>EABRCCOMB</sub>	11.1		14.2		14.2		ns
t <sub>EABRCREG</sub>	8.5		10.8		10.8		ns
t <sub>EABWP</sub>	3.7		4.7		4.7		ns
t <sub>EABWCCOMB</sub>	7.6		9.7		9.7		ns
t <sub>EABWCREG</sub>	14.0		17.8		17.8		ns
t <sub>EABDD</sub>		11.1		14.2		14.2	ns
t <sub>EABDATACO</sub>		3.6		4.6		4.6	ns
t <sub>EABDATASU</sub>	4.4		5.6		5.6		ns
t <sub>EABDATAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWESU</sub>	4.4		5.6		5.6		ns
t <sub>EABWEH</sub>	0.0		0.0		0.0		ns
t <sub>EABWDSU</sub>	4.6		5.9		5.9		ns
t <sub>EABWDH</sub>	0.0		0.0		0.0		ns
t <sub>EABWASU</sub>	3.9		5.0		5.0		ns
t <sub>EABWAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWO</sub>		11.1		14.2		14.2	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Spee	Unit	
Symbol	-		-		-		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>EABAA</sub>		8.1		9.8		13.1	ns
t <sub>EABRCCOMB</sub>	8.1		9.8		13.1		ns
t <sub>EABRCREG</sub>	5.8		6.9		9.3		ns
t <sub>EABWP</sub>	2.0		2.4		3.2		ns
t <sub>EABWCCOMB</sub>	3.5		4.2		5.6		ns
t <sub>EABWCREG</sub>	9.4		11.2		14.8		ns
t <sub>EABDD</sub>		6.9		8.3		11.0	ns
t <sub>EABDATACO</sub>		1.3		1.5		2.0	ns
t <sub>EABDATASU</sub>	2.4		3.0		3.9		ns
t <sub>EABDATAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWESU</sub>	4.1		4.9		6.5		ns
t <sub>EABWEH</sub>	0.0		0.0		0.0		ns
t <sub>EABWDSU</sub>	1.4		1.6		2.2		ns
t <sub>EABWDH</sub>	0.0		0.0		0.0		ns
t <sub>EABWASU</sub>	2.5		3.0		4.1		ns
t <sub>EABWAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWO</sub>		6.2		7.5		9.9	ns

Symbol	-1 Spee	-1 Speed Grade		d Grade	-3 Spee	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>EABAA</sub>		9.7		11.6		16.2	ns
t <sub>EABRCCOMB</sub>	9.7		11.6		16.2		ns
t <sub>EABRCREG</sub>	5.9		7.1		9.7		ns
t <sub>EABWP</sub>	3.8		4.5		5.9		ns
t <sub>EABWCCOMB</sub>	4.0		4.7		6.3		ns
t <sub>EABWCREG</sub>	9.8		11.6		16.6		ns
t <sub>EABDD</sub>		9.2		11.0		16.1	ns
t <sub>EABDATACO</sub>		1.7		2.1		3.4	ns
t <sub>EABDATASU</sub>	2.3		2.7		3.5		ns
t <sub>EABDATAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWESU</sub>	3.3		3.9		4.9		ns
t <sub>EABWEH</sub>	0.0		0.0		0.0		ns
t <sub>EABWDSU</sub>	3.2		3.8		5.0		ns
t <sub>EABWDH</sub>	0.0		0.0		0.0		ns
t <sub>EABWASU</sub>	3.7		4.4		5.1		ns
t <sub>EABWAH</sub>	0.0		0.0		0.0		ns
t <sub>EABWO</sub>		6.1		7.3		11.3	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	1
t <sub>IOD</sub>		1.2		1.3		1.6	ns
t <sub>IOC</sub>		0.4		0.4		0.5	ns
t <sub>IOCO</sub>		0.8		0.9		1.1	ns
t <sub>IOCOMB</sub>		0.7		0.7		0.8	ns
t <sub>IOSU</sub>	2.7		3.1		3.6		ns
t <sub>IOH</sub>	0.2		0.3		0.3		ns
t <sub>IOCLR</sub>		1.2		1.3		1.6	ns
t <sub>OD1</sub>		3.2		3.6		4.2	ns
t <sub>OD2</sub>		5.9		6.7		7.8	ns
t <sub>OD3</sub>		8.7		9.8		11.5	ns
t <sub>XZ</sub>		3.8		4.3		5.0	ns
t <sub>ZX1</sub>		3.8		4.3		5.0	ns
t <sub>ZX2</sub>		6.5		7.4		8.6	ns
t <sub>ZX3</sub>		9.3		10.5		12.3	ns
t <sub>INREG</sub>		8.2		9.3		10.9	ns
t <sub>IOFD</sub>		9.0		10.2		12.0	ns
t <sub>INCOMB</sub>		9.0		10.2		12.0	ns

